Notice of References Cited Application/Control No. 10/750,010 Examiner Kyung H. Shin Applicant(s)/Patent Under Reexamination TAGLIENTI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0127993 A1	09-2002	Zappala, Charles S.	455/404
*	В	US-2004/0260831 A1	12-2004	Dyck et al.	709/233
*	С	US-6,928,280 B1	08-2005	Xanthos et al.	455/423
	D	US-			
	Е	US-			
	F	US-	,		
	G	US-			
	Н	US-			
	. 1	US-			
	J	US-			
	Κ	US-			
	L	US-			
	М	US-		·	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т		,			

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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